**BFU668F** NPN wideband silicon RF transistor Rev. 3 – 24 January 2012

**Product data sheet** 

## 1. Product profile

### 1.1 General description

NPN silicon microwave transistor in a plastic, 4-pin dual-emitter SOT343F package offering an innovative Ku-band DRO solution.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

## **1.2 Features and benefits**

- DROs with good output power and low phase noise at very low current consumption: 5 dBm and –55 dBc/Hz/1 kHz at 12 mA
- Low-noise, high gain for low cost LNA solutions
- 40 GHz f<sub>T</sub> silicon technology

### **1.3 Applications**

- Ku-band DROs in Ku-band LNBs
- C-band, low current LNAs



### 1.4 Quick reference data

Table 1.	Quick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter		-	-	16	V
V <sub>CEO</sub>	collector-emitter voltage	open base		-	-	5.5	V
$V_{\text{EBO}}$	emitter-base voltage	open collector		-	-	2.5	V
I <sub>C</sub>	collector current			-	15	40	mΑ
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 90 \ ^{\circ}C$	[1]	-	-	200	mW
h <sub>FE</sub>	DC current gain	$\begin{array}{l} I_{C} = 10 \text{ mA; } V_{CE} = 3.5 \text{ V;} \\ T_{j} = 25 \ ^{\circ}\text{C} \end{array}$		90	135	200	
C <sub>CBS</sub>	collector-base capacitance	$V_{CB} = 2 V$ ; f = 1 MHz		-	138	-	fF
f <sub>T</sub>	transition frequency	$I_{C} = 15 \text{ mA}; V_{CE} = 3.5 \text{ V};$ f = 2 GHz; T <sub>amb</sub> = 25 °C		-	20	-	GHz
IP3 <sub>o(max)</sub>	maximum output third-order intercept point	$    I_{C} = 15 \text{ mA}; V_{CE} = 3.5 \text{ V};     f = 10 \text{ GHz}; T_{amb} = 25 \text{ °C};     Z_{S} = Z_{L} = 50 \Omega; $		-	24	-	dBm
G <sub>p(max)</sub>	maximum power gain	$    I_{C} = 15 \text{ mA}; V_{CE} = 3.5 \text{ V};     f = 10.0 \text{ GHz};     T_{amb} = 25 \ ^{\circ}\text{C} $	[2]	-	10.5	-	dB
NF	noise figure	$    I_{C} = 15 \text{ mA}; V_{CE} = 3.5 \text{ V};     f = 10.0 \text{ GHz}; \Gamma_{S} = \Gamma_{opt};     T_{amb} = 25 \text{ °C} $		-	1.7	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$    I_{C} = 15 \text{ mA}; V_{CE} = 3.5 \text{ V};     Z_{S} = Z_{L} = 50 \Omega;     f = 10 \text{ GHz}; T_{amb} = 25 \text{ °C} $		-	12	-	dBm

[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

 $\label{eq:general} \mbox{[2]} \quad G_{p(max)} \mbox{ is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{p(max)} = MSG$.}$ 

## 2. Pinning information

#### Table 2.Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base		4
3	emitter		2
4	collector		1, 3
		2 1	mbb159

## 3. Ordering information

Table 3. Orde	ring informa	tion	
Type number	Package		
	Name	Description	Version
BFU668F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F

## 4. Marking

Type number	Marking	Description	
BFU668F	ZA*	* = p : made in Hong Kong	
		* = t : made in Malaysia	
		* = w : made in China	

# 5. Limiting values

#### Table 5. Limiting values

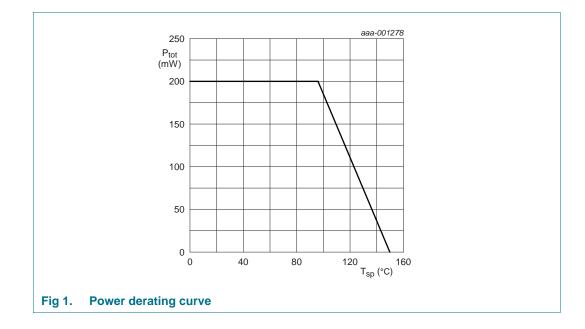
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter	-	16	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	5.5	V
$V_{EBO}$	emitter-base voltage	open collector	-	2.5	V
I <sub>C</sub>	collector current		-	40	mA
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 90 \ ^{\circ}C$	<u>[1]</u> _	200	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

# 6. Thermal characteristics

Table 6.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		270	K/W



# 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	$I_{C} = 2.5 \ \mu A; I_{E} = 0 \ mA$	16	-	-	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	$I_{C} = 1 \text{ mA}; I_{B} = 0 \text{ mA}$	5.5	-	-	V
l <sub>C</sub>	collector current		-	15	40	mA
I <sub>CBO</sub>	collector-base cut-off current	$I_{E} = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	-	100	nA
h <sub>FE</sub>	DC current gain	$I_{C}$ = 10 mA; $V_{CE}$ = 3.5 V	90	135	200	
C <sub>CES</sub>	collector-emitter capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	297	-	fF
C <sub>EBS</sub>	emitter-base capacitance	V <sub>EB</sub> = 0.5 V; f = 1 MHz	-	664	-	fF
C <sub>CBS</sub>	collector-base capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	138	-	fF
f⊤	transition frequency	$I_C$ = 15 mA; $V_{CE}$ = 3.5 V; f = 2 GHz; $T_{amb}$ = 25 °C	-	20	-	GHz
G <sub>p(max)</sub> maximum power gain	maximum power gain	$I_{C}$ = 15 mA; $V_{CE}$ = 3.5 V; $T_{amb}$ = 25 °C	[1]			
		f = 5.8 GHz	-	14.5	-	dB
		f = 10.0 GHz	-	10.5	-	dB
s <sub>21</sub>   <sup>2</sup>	insertion power gain	$I_{C}$ = 15 mA; $V_{CE}$ = 3.5 V; $T_{amb}$ = 25 °C				
		f = 5.8 GHz	-	9.5	-	dB
		f = 10.0 GHz	-	5.0	-	dB
NF	noise figure	$I_C$ = 15 mA; $V_{CE}$ = 3.5 V; $\Gamma_S$ = $\Gamma_{opt}$ ; $T_{amb}$ = 25 °C				
		f = 5.8 GHz	-	1.3	-	dB
		f = 10.0 GHz	-	1.7	-	dB
G <sub>ass</sub>	associated gain	$\label{eq:lc} \begin{array}{l} I_{C} = 15 \; mA; \; V_{CE} = 3.5 \; V; \; \Gamma_{S} = \; \Gamma_{opt}; \\ T_{amb} = 25 \; ^{\circ}C \end{array}$				
		f = 5.8 GHz	-	13	-	dB
		f = 10.0 GHz	-	9.5	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$\label{eq:lc} \begin{array}{l} I_{C} = 15 \text{ mA}; \ V_{CE} = 3.5 \text{ V}; \\ Z_{S} = Z_{L} = 50 \ \Omega; \ T_{amb} = 25 \ ^{\circ}C \end{array}$				
		f = 5.8 GHz	-	13	-	dBm
		f = 10.0 GHz	-	12	-	dBm
IP3 <sub>o(max)</sub>	maximum output third-order intercept point	$\label{eq:lc} \begin{array}{l} I_{C} = 15 \text{ mA}; \ V_{CE} = 3.5 \text{ V}; \\ Z_{S} = Z_{L} = 50 \ \Omega; \ T_{amb} = 25 \ ^{\circ}C \end{array}$				
		f = 5.8 GHz	-	24	-	dBm
		f = 10.0 GHz	-	24	-	dBm

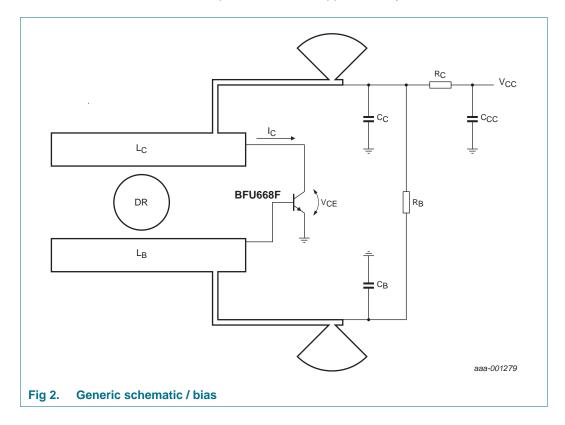
 $\label{eq:general} \mbox{[1]} \quad G_{p(max)} \mbox{ is the maximum power gain, if } K > 1. \mbox{ If } K < 1 \mbox{ then } G_{p(max)} = MSG.$ 

## 8. Application information

#### 8.1 BFU668F Ku-band Dielectric Resonator Oscillator (DRO)

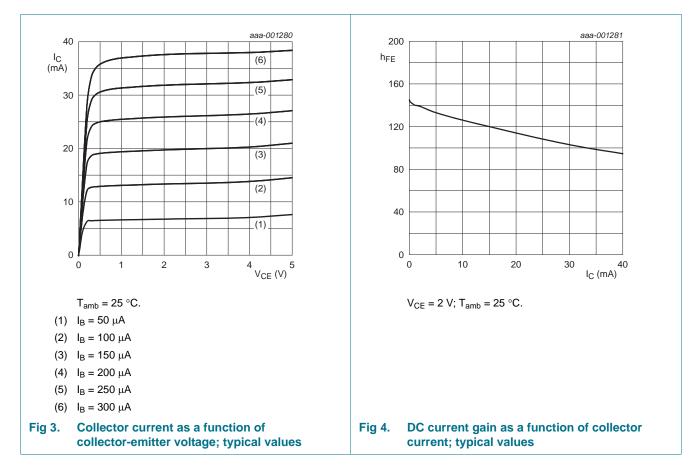
Figure 2 shows a typical DRO circuit using BFU668F as active device. The schematic highlights the bias elements. Evaluation tests, done by replacing the existing transistor with BFU668F, on three different DRO LNBs / configurations, have proven:

- BFU668F achieves similar Phase Noise and RF power as the replaced transistor
- BFU668F achieves same RF performances at approximately half of the bias current



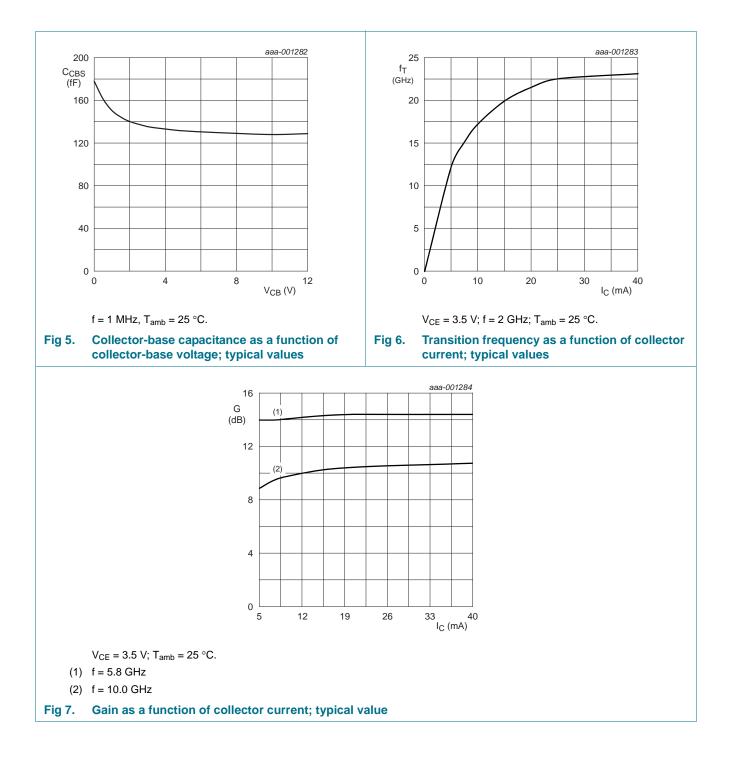
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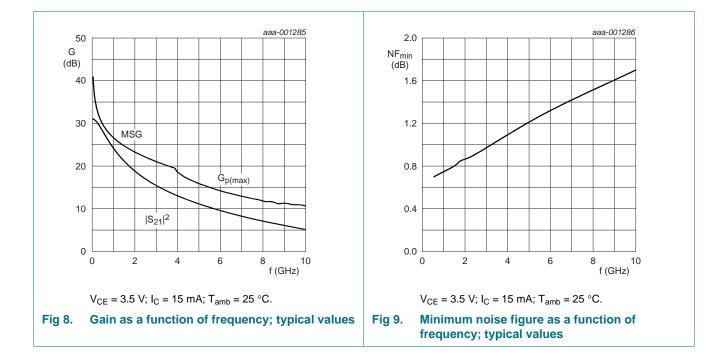
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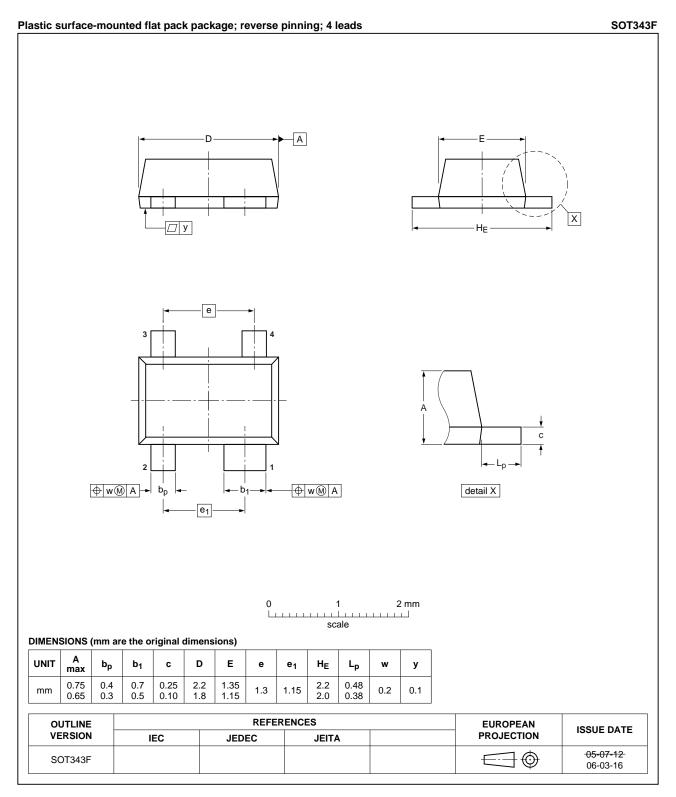


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# 9. Package outline



#### Fig 10. Package outline SOT343F

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# **10. Abbreviations**

Table 8.	Abbreviations
Acronym	Description
DC	Direct Current
DRO	Dielectric Resonator Oscillator
Ku	Kurtz under
LNA	Low Noise Amplifier
LNB	Low Noise Block
NPN	Negative-Positive-Negative
RF	Radio Frequency
-	

# 11. Revision history

Document IDRelease dateData sheet statusChange noticeSupersedesBFU668F v.320120124Product data sheet-BFU668F v.2Modifications:• Table 1 on page 2: maximum value for hFE has been changed. • Table 7 on page 5: maximum value for hFE has been changedBFU668F v.2BFU668F v.220120120Product data sheet-BFU668F v.1BFU668F v.120111108Product data sheet	Table 9. Revision	history			
Modifications: Table 1 on page 2: maximum value for h <sub>FE</sub> has been changed.   • Table 7 on page 5: maximum value for h <sub>FE</sub> has been changed.   BFU668F v.2 20120120 Product data sheet - BFU668F v.1	Document ID	Release date	Data sheet status	Change notice	Supersedes
• Table 7 on page 5: maximum value for h <sub>FE</sub> has been changed.   BFU668F v.2 20120120 Product data sheet - BFU668F v.1	BFU668F v.3	20120124	Product data sheet	-	BFU668F v.2
	Modifications:				
BFU668F v.1 20111108 Product data sheet	BFU668F v.2	20120120	Product data sheet	-	BFU668F v.1
	BFU668F v.1	20111108	Product data sheet	-	-

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Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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